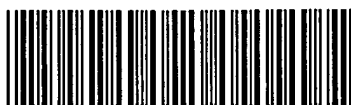


Search Notes

Application/Control No.

10/623,226

Examiner

Shun Lee

Applicant(s)/Patent under
Reexamination

CHAI ET AL.

Art Unit

2878

SEARCHED

Class	Subclass	Date	Examiner
250	361R	2/17/2005	SL
252	301.4F	2/17/2005	SL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
As above with PGPub		2/17/2005	SL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR